

### CTK Co., Ltd.

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# **EMC TEST REPORT For FCC**

FC

Test Report No. : 2005120014-2

Date of Issue : May 08, 2006

FCC ID : NLMDIGIMAXS500

Model/Type No. : Digimax S500

Kind of Product : Digital Camera

Applicant : Samsung Techwin Co., Ltd.

Applicant Address : 145-3 Sangdaewon 1-Dong, Jungwon-Gu, Sungnam-City,

Kyungki-Do, Korea

Manufacturer : 1) Samsung Techwin Co., Ltd.

2) Tianjin Samsung Opto-Electronics Co., LTD.

Manufacturer Address : 1) 42, Sungju-dong, Changwon City, Kyungnam, Korea

2) 7 Pingchang Road, Nabkai Dist., Tianjin, China

Contact Person : Jae-Hyun, Cho (Manager)

Telephone : +82-31-740-8256

Received Date : April 22, 2006

Test period : Start : April 24, 2006 End : April 26, 2006

Test Results :  $\square$  In Compliance  $\square$  Not in Compliance

The test results presented in this report relate only to the object tested.

CTK Co., Ltd. is accredited by Korea Laboratory Accreditation Scheme (KOLAS) which signed the International Laboratory Accreditation Cooperation (ILAC) Mutual Recognition Arrangement (MRA) for the above test item(s) and test method(s).

Tested by

Hee-Sung, Ahn EMC Test Engineer

Date: May 08, 2006

Reviewed by

James Hong

EMC Technical Manager Date: May 08, 2006

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### REPORT REVISION HISTORY

Date Revision		Page No
December 16, 2005	Issued (2005120014)	All
January 27, 2006	Issued (2005120014-1) Alteration of USB/AV cable	All
May 08, 2006	Issued (2005120014-2) Alteration of CCD Sensor and TG IC	All

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# 1.0 General Product Description

### 1.0.1 Tested Equipment

	Model ☐ Tests p	Digimax S500.	del were conducted on
1.0.2	·		and Identification
	Dimensions: Mobility:	Hand-held Traveling	y 61.8 by 32.8 🛚 mm 🗌 inch Table-top 🔲 Built-in Floor-standing
1.0.3	Serial No.: <b>Electrical Ra</b>	Prototype atings	
	Adaptor	Input:	100-240 Vac, 50/60 Hz, 0.15 A
		Output:	3.0 Vdc, 700 mA
	EUT	Input:	3.0 Vdc

## 1.0.4 Test Voltage & Frequency

Unless indicated otherwise on the individual data sheet or test results, the test voltage and frequency was as indicated below.

Voltage: 120 Vac Frequency: 60 Hz

## 1.0.5 Clock & Other Frequencies Utilized

12 MHz, 54 MHz, 108 MHz

### 1.1 Model Differences

Not applicable

### 1.2 Device Modifications

The following modifications were necessary for compliance:

Not applicable

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# 1.3 EUT Configuration(s)

See Appendix A for individual test set-up configuration(s). The following peripheral devices and/or interface cables were connected during the measurement:

Peripheral Devices

Device	Manufacturer	Model No.	Serial No.
Cradle (for EUT)	TIANJIN H&T ELECTRONICS CO., LTD.	SCC-S4	-
Personal Computer	Hewlett-Packard Company	Pavilion t812k	KRJ50403HK
Monitor	Samsung	DP17LS	P232HVCR606455
Keyboard (PS/2 type)	Samsung	SEM-DT35	33008106
Mouse (PS/2 type)	Microsoft	Wheel Mouse 3.0 PS/2 Compatibel	4917590
Printer	Cal-Cmp Electronics(Tailand) Co., Ltd	C6467A	-
Adaptor	YOKOGAWA	AT7001A-01	A0D03P

### □ Cable Description

#	Description	Ferrite Core	Length (m)	Other Details
1	AC power cable, Unshielded	No	1.5	Connect to AC power
2	AC power cable, Unshielded	No	1.5	Connect to AC power
3	AC power cable, Unshielded	No	1.5	Connect to AC power
4	Cradle Power Cable, Unshielded	No	1.5	Connect to AC power
5	USB cable, Shielded	No	1.2	Between the Cradle and PC
6	Monitor cable, Shielded	Yes	1.2	Between the PC and Monitor
7	Keyboard cable, Shielded	No	1.5	PS/2 type
8	Mouse cable, Shielded	No	1.5	PS/2 type
9	Printer cable, Shielded	No	1.5	Between the PC and Printer
10	Adaptor cable, Unshielded	Yes	1.5	Between the Adaptor and Printer

### 1.4 Test Software EMC Test V 1.0 Display Test Patterns - V1.5 Ping.exe Not applicable 1.5 **EUT Operating Mode(s)** Equipment under test was operated during the measurement under the following conditions: Standby Scrolling 'H' Display circles pattern ☐ Read / Write □ Practice operation – USB downloading mode. AV output monitoring mode

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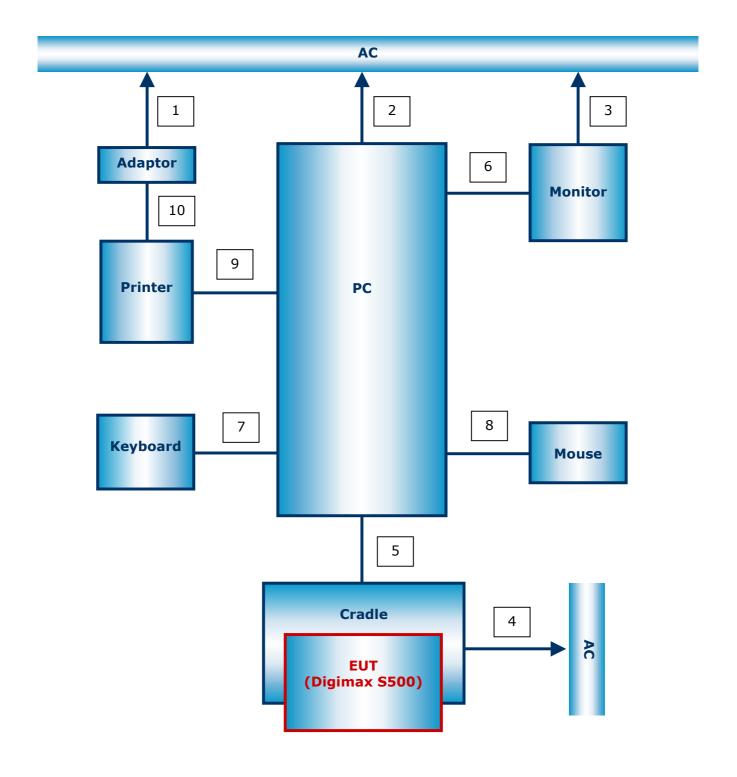
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# 1.6 Configuration



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# 1.7 Calibration Details of Equipment Used for Measurement

Test equipment and test accessories are calibrated on regular basis. The maximum time between calibrations is one year or what is recommended by the manufacturer, whichever is less. All test equipment calibrations are traceable to the Korea Research Institute of Standards and Science (KRISS), therefore, all test data recorded in this report is traceable to KRISS.

# 1.8 Test Facility

The measurement facility is located at 386-1, Ho-dong, Cheoin-gu, Yongin-si, Gyeonggi-do, 449-100, Korea. The sites are constructed in conformance with the requirements of ANSI C63.7, ANSI C63.4 and CISPR Publication 22.

### 1.9 Measurement Procedure

Preliminary AC power line conducted emissions tests were performed shielded room. To find worst mode, several typical mode and typical cable position were tested. Final AC power line conducted emissions test was performed shielded room. (location is same as Preliminary test)

Based on the preliminary tests of the EUT, final test was proceeded worst case test mode and cable configuration.

Preliminary radiated emissions test were performed anechoic chamber (Distance of antenna and EUT was 3 m). To find worst mode, several typical mode and typical cable position were tested and peak level and frequency were recorded.

Final radiated emissions test was performed Open Area Test Site. Based on the preliminary tests of the EUT, final test was proceeded worst case test mode and cable configuration.

\* Measurement procedures was In accordance with ANSI C63.4-2003 7.2.3, 7.2.4, 8.3.1.1, 8.3.1.2

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# 1.10 Laboratory Accreditations and Listings

Country	Agency	Scope of Accreditation	Logo
USA	FCC	3 & 10 meter Open Area Test Sites and one conducted site to perform FCC Part 15/18 measurements.	FC 93250
JAPAN	VCCI	10 meter Open Area Test Site and one conducted site.	<b>V</b> (I) R-948, C-986
KOREA	MIC	EMI (10 meter Open Area Test Site and two conducted sites) EMS (ESD, RS, EFT/Burst, Surge, CS, Magnetic, Dips and interruptions)	No. 51, KR0025
International	KOLAS	EMC	KOLAS OF TESTING NO.119 SHEET
Europe	GLAS	EMC EN 55011, EN 55022, EN 61000-6-3, EN 61000-6-4, EN 61000-3-2, EN 61000-3-3, EN 61000-6-1, EN 61000-6-2, EN 50130-4, EN 55024, EN 61204-3, EN 60601-1-2, EN 61000-4-2, EN 61000-4-3, EN 61000-4-4, EN 61000-4-5, EN 61000-4-6, EN 61000-4-8, EN 61000-4-11	<b>TÜV</b> No.13000796-02

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# 2.0 Emissions Test Regulations

The emissions tests were performed according	to following regulations	<b>:</b>
☐ EN 61000-6-3:2001	☐ Class A	☐ Class B
☐ EN 61000-6-4:2001	☐ Class A	☐ Class B
☐ EN 50083-2:2001		
☐ EN 55011:1998 +A1:1999	Group 1	Group 2
☐ EN 55011:1998 +A1:1999 +A2:2002	☐ Class A ☐ Group 1 ☐ Class A	☐ Class B☐ Group 2☐ Class B
☐ EN 55013:1990 +A12:1994 +A13:1996 +A☐ EN 55013:2001	A14:1999	
☐ EN 55014-1:2000 ☐ EN 55014-1:2000 +A1:2001		
☐ EN 55015:2000 ☐ EN 55015:2000 +A1:2001		
☐ EN 55022:1994 +A1:1995 +A2:1997 ☐ EN 55022:1998 ☐ EN 55022:1998 +A1:2000 ☐ EN 55022:1998 +A1:2000 +A2:2003	☐ Class A ☐ Class A ☐ Class A ☐ Class A	Class B Class B Class B Class B
☐ EN 61000-3-2:2000		
☐ EN 61000-3-3:1995 +A1:2001		
☐ VCCI V-3/2004.04	☐ Class A	☐ Class B
☐ AS/NZS 3548:1995 +A1:1997 +A2:1997	☐ Class A	☐ Class B
	☐ Class A	⊠ Class B
□ CISPR 22:1997     The unit was tested to CISPR 22 and complied FCC under paragraphs 15.107 and 15.109.	☐ Class A with the alternate meth	⊠ Class B nods allowed by
☐ CISPR 22:1997 +A1:2000	☐ Class A	☐ Class B

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# 2.1 Conducted Voltage Emissions

#### **Test Date**

April 26, 2006

#### **Test Location**

Shielded Room

### **Test Equipment**

	Name of Equipment	Manufacturer	Model No.	Serial No.	Due Date
$\boxtimes$	Field Strength Meter	Rohde & Schwarz	ESHS30	828144/002	2007-02-10
$\boxtimes$	LISN	EMCO	3825/2	9607-2575	2006-09-03
	LISN	EMCO	3825/2	9409-2246	2006-09-03

### **Frequency Range of Measurement**

150 kHz to 30 MHz

### **Instrument Settings**

IF Band Width: 9 kHz

#### **Test Results**

The requirements are:

MET			
Frequency (MHz)	Measured Data (dBuV)	Margin (dB)	Remark
2.63	42.6	3.4	Average

■ NOT MET			
Frequency (MHz)	Measured Data (dBuV)	Margin (dB)	Remark

■ NOT APPLICABLE

#### **Remarks**

See Appendix A for test data.

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### 2.2 Radiated Electric Field Emissions

#### **Test Date**

April 24, 2006

### **Test Location**

☐ Testing was performed at a test distance of 3 & 10 meter Open Area Test Site

### **Test Equipment**

	Name of Equipment	Manufacturer	Model No.	Serial No.	Due Date
$\boxtimes$	Field Strength Meter	Rohde & Schwarz	ESVS30	829673/015	2007-01-09
$\boxtimes$	EMC Analyzer	Agilent Technologies	E7403A	MY42000054	2007-01-15
$\boxtimes$	ULTRA Broadband Antenna	Rohde & Schwarz	HL562	361324/014	2006-05-27

## **Frequency Range of Measurement**

30 MHz to 1 GHz: 10 meter Open Area Test Site 1 GHz to 2 GHz: 3 meter Open Area Test Site

# **Instrument Settings**IF Band Width: 120 kHz

#### **Test Results**

The requirements are:

	Measured Data (dBuV/m)	Margin (dB)	Remark
433.00	31.1	5.9	Quasi-peak
433.00	31.1	5.9	Quasi-peak

□ NOT MET										
Frequency (MHz)	Measured Data (dBuV/m)	Margin (dB)	Remark							

■ NOT APPLICABLE

### Remarks

See Appendix A for test data.

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# **APPENDIX A - TEST DATA**

# **Conducted Voltage Emissions**

Frequency	Correction		Line	Quasi-peak				Average			
. ,	Factor			Limit	Reading	Result	Margin	Limit	Reading	Result	Margin
[MHz]	LISN	Cable		[dBuV]	[dBuV]	[dBuV]	[dB]	[dBuV]	[dBuV]	[dBuV]	[dB]
2.63	0.1	0.2	Н	56.0	51.8	52.1	3.9	46.0	42.3	42.6	3.4
6.09	0.3	0.2	N	60.0	53.3	53.8	6.2	50.0	42.0	42.5	7.5
6.68	0.3	0.2	Н	60.0	55.6	56.1	3.9	50.0	45.3	45.8	4.2
6.70	0.3	0.2	Н	60.0	55.9	56.4	3.6	50.0	45.0	45.5	4.5
6.76	0.3	0.2	Н	60.0	55.5	56.0	4.0	50.0	45.0	45.5	4.5
6.84	0.3	0.2	Н	60.0	55.7	56.2	3.8	50.0	44.9	45.4	4.6
6.88	0.3	0.2	Н	60.0	55.6	56.1	3.9	50.0	44.8	45.3	4.7

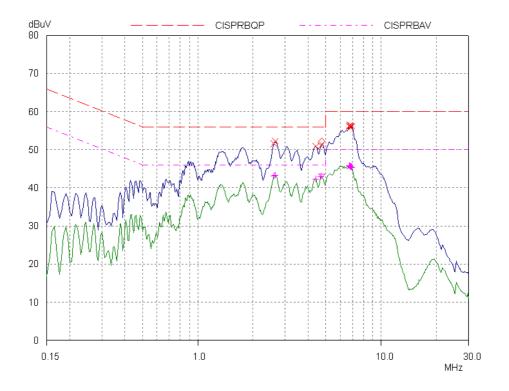
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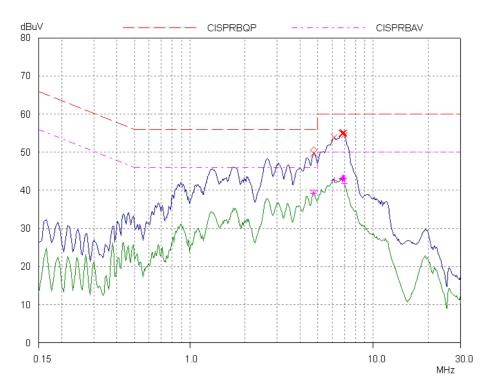
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### **Radiated Electric Field Emissions**

Frequency	Reading	Pol.	Height	Correction Factor		Limits	Result	Margin
[MHz]	[dBuV/m]		[m]	Antenna	Cable	[dBuV/m]	[dBuV/m]	[dB]
162.30	7.1	V	1.2	6.9	2.4	30.0	16.4	13.6
216.30	6.5	Н	4.0	7.8	2.8	30.0	17.1	12.9
324.50	14.9	V	1.0	11.3	3.4	37.0	29.6	7.4
378.75	14.4	V	1.0	12.7	3.7	37.0	30.8	6.2
433.00	13.3	Н	3.6	13.9	3.9	37.0	31.1	5.9
487.25	10.2	V	1.2	15.2	4.3	37.0	29.7	7.3
539.75	8.6	V	1.5	16.0	4.4	37.0	29.0	8.0

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